

## T50N-1200

### STUD TYPETHYRISTOR

#### Features

- Hermetic ceramic -metal seal
- high dv/dt
- tested according to IEC standards
- High surge capability
- Compression Bonded Encapsulation for heavy duty operations such as severe thermal cycling

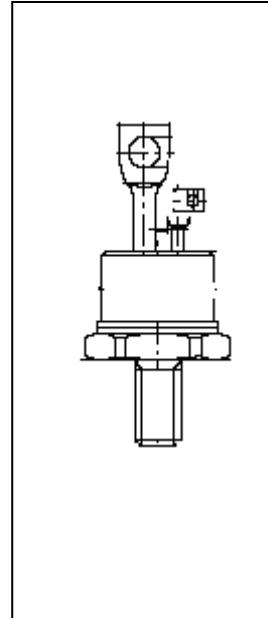
**50A**

#### Typical Applications

- DC motor controls
- Controlled DC power supplies
- AC controllers

#### Major Ratings and Characteristics

Parameters	T50N12	Units
I <sub>T(AV)</sub>	50	A
@ T <sub>c</sub>	90	°C
I <sub>T(RMS)</sub>	80	A
I <sub>TSM</sub>	2.7	A
@ 50Hz	2.83	A
I <sup>2</sup> t	36.4	KA <sup>2</sup> s
@ 60Hz	33.2	KA <sup>2</sup> s
V <sub>DRM</sub> /V <sub>RRM</sub>	120	V
T <sub>q</sub> typical	260	μs
T <sub>J</sub> range	- 40 to 125	°C



## T50N-1200

### ELECTRICAL SPECIFICATIONS

#### Voltage Ratings

Type number	Voltage Code	$V_{RRM}/V_{DRM}$ , maximum repetitive peak reverse voltage V	$V_{RSM}$ , maximum non-repetitive peak rev. voltage V	$I_{RRM}/I_{DRM}$ max. @ $T_J = T_{J\max}$ . mA
T50N12	02	200	300	20
	06	600	700	
	10	1000	1100	
	12	1200	1300	
	15	1500	1600	

#### On-state Conduction

Parameter	T50N12	Units	Conditions			
$I_{T(AV)}$ Maximum average on-state current @ Case temperature	50	A	180° conduction, half sine wave			
	90	°C				
$I_{(RMS)}$ Maximum RMS on-state current	80	A	180° conduction, half sine wave @ $T_c = 80^\circ C$			
$I_{TSM}$ , Maximum peak, one-cycle non-repetitive surge current	2700	A	$t = 10ms$	No voltage reapplied	Sinusoidal half wave, Initial $T = T_{\max}$ .	
	2830		$t = 8.3ms$	$100\% V_{RRM}$ reapplied		
	2270		$t = 10ms$			
	2380		$t = 8.3ms$	reapplied		
$I^2 t$ Maximum $I^2 t$ for fusing	36.4	KA <sup>2</sup> s	$t = 10ms$	No voltage reapplied	Initial $T = T_{\max}$ .	
	33.2		$t = 8.3ms$	$100\% V_{RRM}$ reapplied		
	25.8		$t = 10ms$			
	23.5		$t = 8.3ms$	reapplied		
$I^2 \sqrt{t}$ Maximum $I^2 \sqrt{t}$ for fusing	364	KA <sup>2</sup> √s	$t = 0.1$ to $10ms$ , no voltage reapplied			
$V_{TM}$ Maximum on-state or forward	1.52	V	$pk = 600A$ , $T_J = 25^\circ C$ , $t_p = 10ms$ sine pulse			
$I_H$ Maximum holding current	600	mA	$T_J = 25^\circ C$ , anode supply 12V resistive load			
$I_L$ Typical latching current	1000					

#### Switching

Parameter	T50N12	Units	Conditions	
$di/dt$ ax. non-repetitive rate of rise of turned-on current	500	A/μs	Gate drive 20V, $20\Omega$ , $tr \leq 1\mu s$ $T_J = T_{J\max}$ , anode voltage $\leq 80\% V_{DRM}$	
$t_d$ ical delay time	2.0	μs	Gate current 1A, $di/dt = 1A/\mu s$ $V_d = 0.67\% V_{DRM}$ , $T_J = 25^\circ C$	
$T_q$ pical turn-off time	260	μs	$I_{TM} = 300A$ , $T_J = T_{J\max}$ , $di/dt = 20A/\mu s$ , $V_R = 50V$ $dv/dt = 20V/\mu s$ , Gate 0V $100\Omega$ , $t_p = 500\mu s$	

**T50N-1200****Blocking**

Parameter	T50N12	Unit s	Conditions
dv/dt Maximum critical rate of rise of off-state voltage	500	V/μs	T <sub>J</sub> = T <sub>J</sub> max linear to 80% rated V <sub>DRM</sub>
I <sub>DRM</sub> Max. peak reverse and off-state leakage current	20	mA	T <sub>J</sub> = T <sub>J</sub> max, rated V <sub>DRM</sub> /V <sub>RRM</sub> applied

**Triggering**

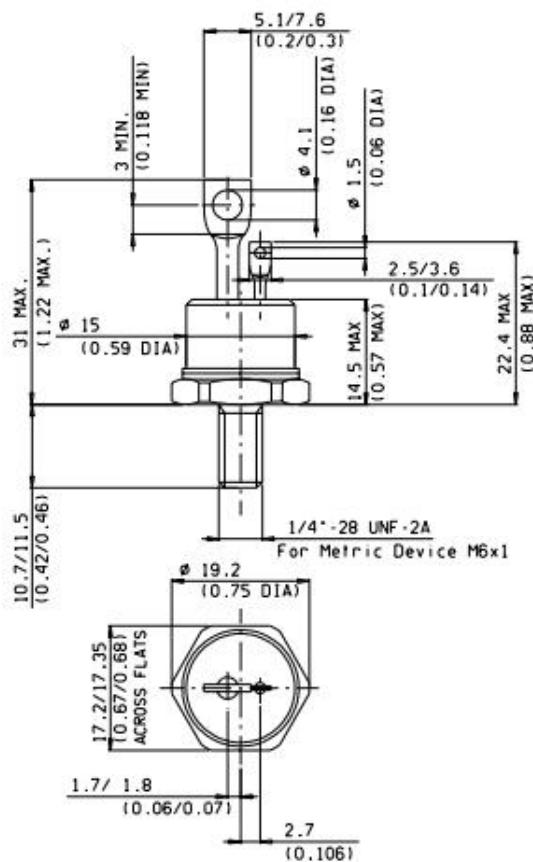
Parameter	T50N12		Units	Conditions
P <sub>GM</sub> Maximum peak gate power	5		W	T <sub>J</sub> = T <sub>J</sub> max, t <sub>p</sub> ≤ 5ms
P <sub>G(AV)</sub> Maximum average gate power				T <sub>J</sub> = T <sub>J</sub> max, f = 50Hz, d% = 50
I <sub>GM</sub> Max. peak positive gate current	2.0		A	T <sub>J</sub> = T <sub>J</sub> max, t <sub>p</sub> ≤ 5ms
+V <sub>GM</sub> Maximum peak positive gate voltage	20		V	T <sub>J</sub> = T <sub>J</sub> max, t <sub>p</sub> ≤ 5ms
-V <sub>GM</sub> Maximum peak negative gate voltage				
I <sub>GT</sub> DC gate current required to trigger	TYP.	MAX.	mA	T <sub>J</sub> = -40°C T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C Max. required gate trigger/ current/ voltage are the lowest value which will trigger all units 12V anode-to-cathode applied
	180	-		
	90	150		
	40	-		
V <sub>GT</sub> DC gate voltage required to trigger	2.9	-	V	T <sub>J</sub> = -40°C T <sub>J</sub> = 25°C T <sub>J</sub> = 125°C
	1.8	30		
	1.2	-		
I <sub>GD</sub> DC gate current not to trigger	8		mA	Max. gate current/ voltage not to trigger is the max. value which will not trigger any unit with rated V anode-to-cathode applied
V <sub>GD</sub> DC gate voltage not to trigger	0.25		V	

**Thermal and Mechanical Specification**

Parameter	T50N12	Units	Conditions
T <sub>J</sub> Max. operating temperature range	-40 to 125	°C	
T <sub>stg</sub> Max. storage temperature range	-40 to 150		
R <sub>thJC</sub> Max. thermal resistance, junction to case	0.195	K/W	DC operation
R <sub>thCS</sub> Max. thermal resistance, case to heatsink	0.08		Mounting surface, smooth, flat and greased
T Mounting torque, ± 10%	15.5(137)	Nm (lbf-in)	Non lubricated threads
	14(120)		Lubricated threads
wt Approximate weight	0.03	Kg	

**T50N-1200**

Outline Table



### T50N-1200

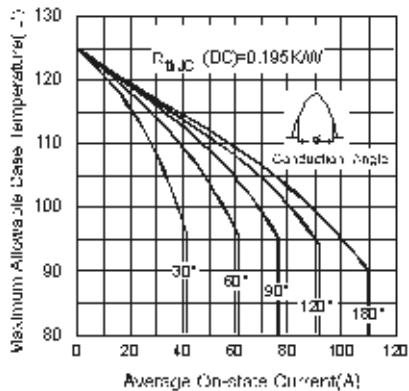


Fig.1-Current Rating Characteristics

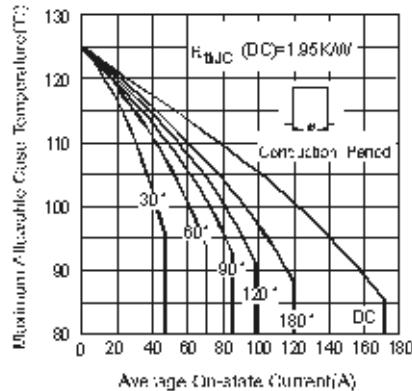


Fig.2-Current Rating Characteristics

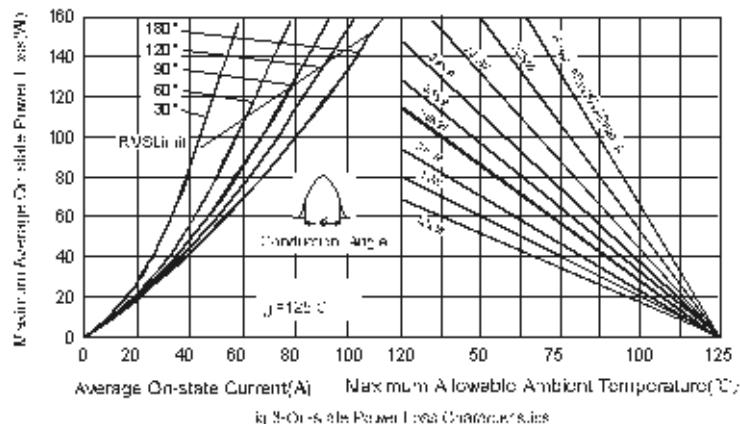


Fig.3-On-state Power Loss Characteristics

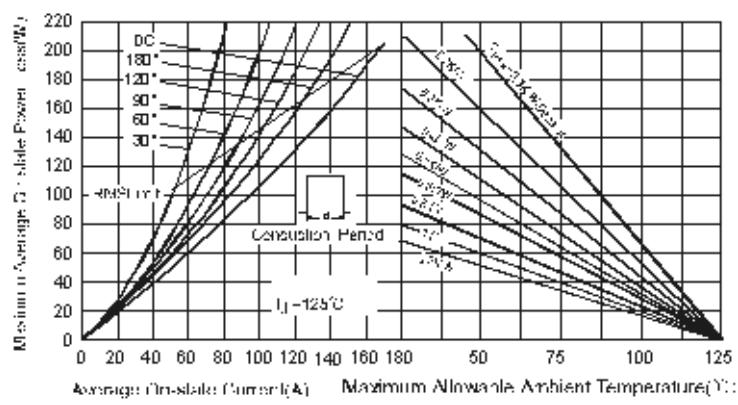


Fig.4-On-state Power Loss Characteristics

## T50N-1200

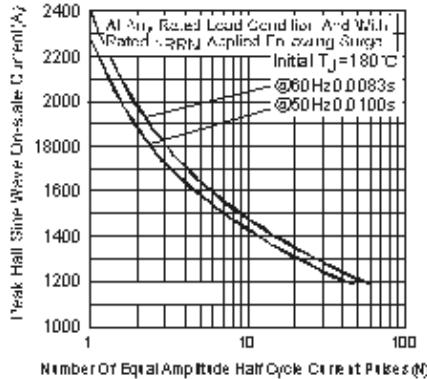


Fig.5-Maximum Non-Repetitive Surge Current

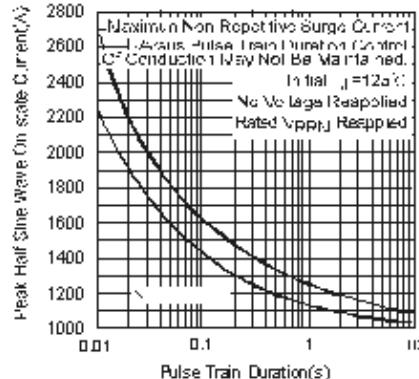


Fig.6-Maximum Non-Repetitive Surge Current

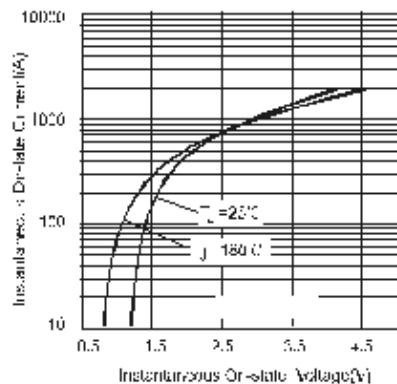
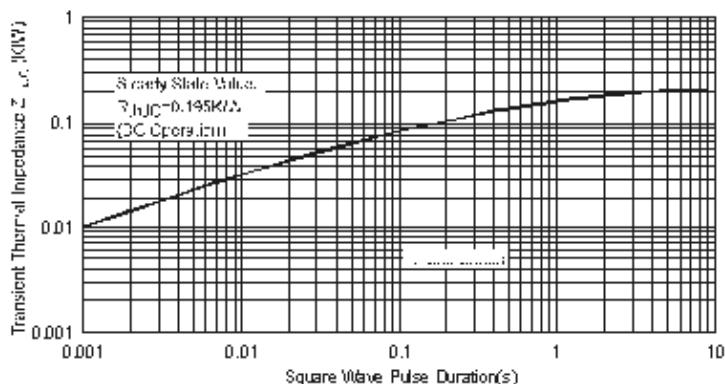


Fig.7-On-state Voltage Drop Characteristics

Fig.8-Thermal Impedance  $Z_{thJC}$  Characteristics

# X-ON Electronics

Largest Supplier of Electrical and Electronic Components

***Click to view similar products for GREEGOO manufacturer:***

Other Similar products are found below :

[100U160M](#) [16HFR120M](#) [85HF160M](#) [KS100N12](#) [MDS-100-12F](#) [MDS-160-12F](#) [MDS-500-12F](#) [SGBJ3516](#) [SKBPC3516](#) [T100N12](#) [T30N12](#)

[UDS-A-200](#) [UDS-A-300](#) [UDS-A-400](#)